## Notice of References Cited Application/Control No. 10/530,308 Applicant(s)/Patent Under Reexamination VAN PIETERSON ET AL. Examiner Steven J. Fulk Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,608,283 A	03-1997	Twichell et al.	313/309
*	В	US-6,448,701 B1	09-2002	Hsu, David S. Y.	313/309
*	С	US-6,472,802 B1	10-2002	Choi et al.	313/309
*	D	US-2002/0175323 A1	11-2002	Guillom et al.	257/10
*	Ε	US-2003/0039750 A1	02-2003	Mao et al.	427/180
*	F	US-6,774,548 B2	08-2004	Fran et al.	313/309
*	G	US-6,935,915 B2	08-2005	Park et al.	445/24
*	Н	US-2002/0094494	07-2002	Chung et al.	430/311
	1	US-			
	7	US-			
	Κ	US-			
	ك	US-			
	Δ	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

	NON-PATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
•	٧						
	w						
	x						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.